# CY74FCT2543T 8-BIT LATCHED TRANSCEIVER WITH 3-STATE OUTPUTS

SCCS042C - SEPTEMBER 1994 - REVISED NOVEMBER 2001

24 VCC

22 B<sub>0</sub>

21 B1

20 B<sub>2</sub>

19 B<sub>3</sub>

18 B<sub>4</sub>

17 B<sub>5</sub>

16 B<sub>6</sub>

15 B<sub>7</sub>

13

14 LEAB

OEAB

23 CEBA

Q OR SO PACKAGE (TOP VIEW)

LEBA

OEBA [

2

А<sub>0</sub> [] з

A<sub>1</sub> 4

A<sub>2</sub> 5

A<sub>4</sub> [] 7

A<sub>5</sub> 8

A<sub>6</sub> 🛛 9

А7Ц

CEAB 11

GND [

10

12

A<sub>3</sub> 6

- Function and Pinout Compatible With FCT and F Logic
- 25-Ω Output Series Resistors to Reduce Transmission-Line Reflection Noise
- Reduced V<sub>OH</sub> (Typically = 3.3 V) Versions of Equivalent FCT Functions
- Edge-Rate Control Circuitry for Significantly Improved Noise Characteristics
- I<sub>off</sub> Supports Partial-Power-Down Mode Operation
- Matched Rise and Fall Times
- Fully Compatible With TTL Input and Output Logic Levels
- 12-mA Output Sink Current
  15-mA Output Source Current
- Separation Controls for Data Flow in Each Direction
- Back-to-Back Latches for Storage
- ESD Protection Exceeds JESD 22
  - 2000-V Human-Body Model (A114-A)
  - 200-V Machine Model (A115-A)
    - 1000-V Charged-Device Model (C101)
- 3-State Outputs

# description

The CY74FCT2543T octal latched transceiver contains two sets of eight D-type latches. Separate latch enable (LEAB, LEBA) and output enable (OEAB, OEBA) inputs permit each latch set to have independent control of inputting and outputting in either direction of data flow. For example, for data flow from A to B, the A-to-B enable (CEAB) input must be low to enter data from A or to take data from B, as indicated in the function table. With CEAB low, a low signal on the A-to-B latch enable (LEAB) input makes the A-to-B latches transparent; a subsequent low-to-high transition of LEAB puts the A latches in the storage mode and their outputs no longer change with the A inputs. With CEAB and OEAB both low, the 3-state B output buffers are active and reflect data present at the output of the A latches. Control of data from B to A is similar, but uses CEAB, LEAB, and OEAB inputs. On-chip termination resistors at the outputs reduce system noise caused by reflections. The CY74FCT2543T can replace the CY74FCT543T to reduce noise in an existing design.

This device is fully specified for partial-power-down applications using I<sub>off</sub>. The I<sub>off</sub> circuitry disables the outputs, preventing damaging current backflow through the device when it is powered down.



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PIN DESCRIPTION

NAME	DESCRIPTION							
OEAB	A-to-B output-enable input (active low)							
OEBA	B-to-A output-enable input (active low)							
CEAB	A-to-B enable input (active low)							
CEBA	B-to-A enable input (active low)							
LEAB	A-to-B latch-enable input (active low)							
LEBA	B-to-A latch-enable input (active low)							
А	A-to-B data inputs or B-to-A 3-state outputs							
В	B-to-A data inputs or A-to-B 3-state outputs							

## **ORDERING INFORMATION**

TA	PACI	(AGE <sup>†</sup>	SPEED (ns)	ORDERABLE PART NUMBER	TOP-SIDE MARKING
	QSOP – Q T		5.3	CY74FCT2543CTQCT	FCT2543C
	SOIC – SO	Tube	5.3	CY74FCT2543CTSOC	FCT2543C
	SOIC - SO	Tape and reel	5.3	CY74FCT2543CTSOCT	FC12543C
–40°C to 85°C	QSOP – Q	Tape and reel	6.5	CY74FCT2543ATQCT	FCT2543A
	SOIC – SO	Tube	6.5	CY74FCT2543ATSOC	FCT2543A
	SOIC - SO	Tape and reel	6.5	CY74FCT2543ATSOCT	FC12543A
	QSOP – Q	Tape and reel	8.5	CY74FCT2543TQCT	FCT2543

<sup>†</sup>Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

#### **FUNCTION TABLE**

	INPUTS		LATCH	OUTPUT
CEAB	LEAB	OEAB	А-ТО-В‡	В
Н	Х	Х	Storing	Z
х	Н	Х	Storing	Х
х	Х	Н	х	Z
L	L	L	Transparent	Current A inputs
L	Н	L	Storing	Previous A inputs

<sup>‡</sup>Before LEAB low-to-high transition

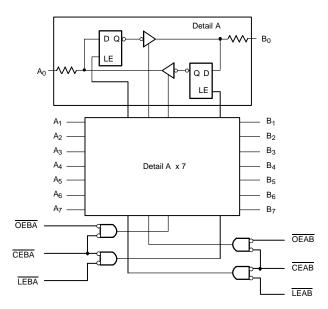
H = High logic level, L = Low logic level, X = Don't care,

Z = High-impedance state

A-to- $\overline{B}$  data flow shown; B-to-A is the same, except using  $\overline{CEBA}$ ,  $\overline{LEBA}$ , and  $\overline{OEBA}$ .



# functional block diagram



## absolute maximum rating over operating free-air temperature range (unless otherwise noted)<sup>†</sup>

Supply voltage range to ground potential	–0.5 V to 7 V
DC input voltage range	–0.5 V to 7 V
DC output voltage range	–0.5 V to 7 V
DC output current (maximum sink current/pin)	120 mA
Package thermal impedance, $\theta_{JA}$ (see Note 1): Q package	61°C/W
SO package	46°C/W
Ambient temperature range with power applied, T <sub>A</sub>	–65°C to 135°C
Storage temperature range, T <sub>stg</sub>	−65°C to 150°C
•	

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: The package thermal impedance is calculated in accordance with JESD 51-7.

# recommended operating conditions (see Note 2)

		MIN	NOM	MAX	UNIT
Vcc	Supply voltage	4.75	5	5.25	V
VIH	High-level input voltage	2			V
VIL	Low-level input voltage			0.8	V
ЮН	High-level output current			-15	mA
I <sub>OL</sub>	Low-level output current			12	mA
TA	Operating free-air temperature	-40		85	°C

NOTE 2: All unused inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation.



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## electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS		MIN	TYP†	MAX	UNIT
VIK	V <sub>CC</sub> = 4.75 V,	V <sub>CC</sub> = 4.75 V, I <sub>IN</sub> = -18 mA					
VOH	V <sub>CC</sub> = 4.75 V,	I <sub>OH</sub> = -15 mA		2.4	3.3		V
VOL	V <sub>CC</sub> = 4.75 V,	I <sub>OL</sub> = 12 mA			0.3	0.55	V
R <sub>out</sub>	V <sub>CC</sub> = 4.75 V,	I <sub>OL</sub> = 12 mA		20	25	40	Ω
V <sub>hys</sub>	All inputs				0.2		V
IН	V <sub>CC</sub> = 5.25 V	$V_{IN} = V_{CC}$ $V_{IN} = 2.7 V$				5 ±1	μA
١ <sub>IL</sub>	V <sub>CC</sub> = 5.25 V,	$V_{IN} = 0.5 V$				±1	μA
IOZH	$V_{\rm CC} = 5.25  \text{V},$	V <sub>OUT</sub> = 2.7 V				15	μA
IOZL	V <sub>CC</sub> = 5.25 V,	V <sub>OUT</sub> = 0.5 V				-15	μA
los‡	V <sub>CC</sub> = 5.25 V,	V <sub>OUT</sub> = 0 V		-60	-120	-225	mA
l <sub>off</sub>	V <sub>CC</sub> = 0 V,	V <sub>OUT</sub> = 4.5 V			±1	μA	
ICC	V <sub>CC</sub> = 5.25 V,	$V_{IN} \leq 0.2V$ ,	$V_{IN} \ge V_{CC} - 0.2 V$		0.1	0.2	mA
∆ICC	V <sub>CC</sub> = 5.25 V, V <sub>IN</sub> = 3.4 V§, f	= 0, Outputs open			0.5	2	mA
ICCD	$\frac{V_{CC}}{CEAB} = 5.25 \text{ V}, \text{ One input switc} \\ \overline{CEAB} \text{ and } \overline{OEAB} = LOW, \overline{CEE} \\ V_{IN} \le 0.2 \text{ V or } V_{IN} \ge V_{CC} - 0 \\ \end{array}$	BA = HIGH,	utputs open,		0.06	1.2	mA/ MHz
	V <sub>CC</sub> = 5.25 V, f <sub>0</sub> = 10 MHz,	One bit switching at f <sub>1</sub> = 5 MHz	$\begin{array}{l} V_{IN} \leq 0.2 \ V \ or \\ V_{IN} \geq V_{CC} - 0.2 \ V \end{array}$		0.7	1.4	
IC#	$\frac{\text{Outputs open,}}{\text{CEAB}} = \text{LOW,}$	at 50% duty cycle	$V_{IN} = 3.4 \text{ V or GND}$		1.2	3.4	mA
۱ <i>۲</i>	$\frac{CEAB}{CEBA} = HIGH,$ f <sub>0</sub> = LEAB = 10 MHz	Eight bits switching at f <sub>1</sub> = 5 MHz	$\begin{array}{l} V_{IN} \leq 0.2 \ V \ or \\ V_{IN} \geq V_{CC} - 0.2 \ V \end{array}$		2.8	5.6ll	ШA
		at 50% duty cycle	$V_{IN} = 3.4 \text{ V or GND}$		5.1	14.6	
Ci					5	10	pF
Co					9	12	pF

<sup>†</sup> Typical values are at  $V_{CC} = 5 V$ ,  $T_A = 25^{\circ}C$ .

<sup>‡</sup> Not more than one output should be shorted at a time. Duration of short should not exceed one second. The use of high-speed test apparatus and/or sample-and-hold techniques are preferable to minimize internal chip heating and more accurately reflect operational values. Otherwise, prolonged shorting of a high output can raise the chip temperature well above normal and cause invalid readings in other parametric tests. In any sequence of parameter tests, IOS tests should be performed last.

§ Per TTL-driven input ( $V_{IN}$  = 3.4 V); all other inputs at V<sub>CC</sub> or GND

- This parameter is derived for use in total power-supply calculations.
- <sup>#</sup>IC  $= I_{CC} + \Delta I_{CC} \times D_H \times N_T + I_{CCD} (f_0/2 + f_1 \times N_1)$
- Where:
- = Total supply current IC
- I<sub>CC</sub> = Power-supply current with CMOS input levels
- $\Delta I_{CC}$  = Power-supply current for a TTL high input (VIN = 3.4 V)
- D<sub>H</sub> = Duty cycle for TTL inputs high
- NT = Number of TTL inputs at DH
- I<sub>CCD</sub> = Dynamic current caused by an input transition pair (HLH or LHL)
- = Clock frequency for registered devices, otherwise zero fo
- = Input signal frequency f1
- = Number of inputs changing at f1 N1

All currents are in milliamperes and all frequencies are in megahertz.

I Values for these conditions are examples of the ICC formula.



# timing requirements over recommended operating free-air temperature range (unless otherwise noted) (see Figure 1)

		METER	CY74FC	FCT2543T CY74FCT2543AT			CY74FCT2	UNIT	
	FARA	MIN	MAX	MIN	MAX	MIN	MAX	UNIT	
tw	tw Pulse duration, LEBA or LEAB low				5		5		ns
t <sub>su</sub>	Setup time, high or low	ow A or B before $\overline{\text{LEBA}}\downarrow$ or $\overline{\text{LEAB}}\downarrow$			2		2		ns
th	Hold time, high or low	A or B after $\overline{\text{LEBA}}\downarrow$ or $\overline{\text{LEAB}}\downarrow$	2		2		2		ns

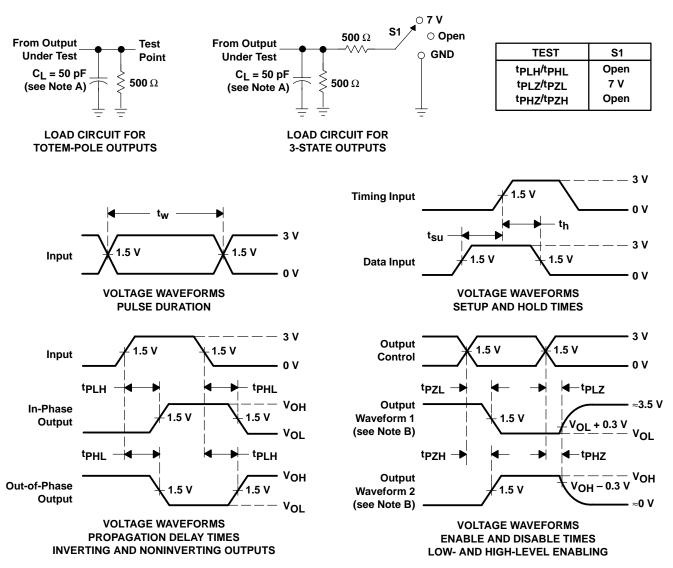
# switching characteristics over operating free-air temperature range (see Figure 1)

PARAMETER	FROM	то	CY74FC	T2543T	CY74FCT	2543AT	CY74FCT	UNIT	
PARAMETER	(INPUT)	(OUTPUT)	MIN	MIN MAX MIN MAX		MIN	MAX		
<sup>t</sup> PLH	A or B	B or A	2.5	8.5	2.5	6.5	2.5	5.5	ns
<sup>t</sup> PHL	AUB	BOIX	2.5	0.0	2.5	0.5	2.0	5.5	115
<sup>t</sup> PLH	LEBA or LEAB	A or B	2.5	12.5	2.5	8	2.5	7	ns
<sup>t</sup> PHL		AOLP	2.5	12.5	2.5	0	2.0	'	115
<sup>t</sup> PZH	OEBA or OEAB	A or B	2	12	2	9	2	8	ns
<sup>t</sup> PZL		AUR	2	12	2	9	2	8	113
<sup>t</sup> PZH		A or B	2	12	2	9	2	8	20
<sup>t</sup> PZL	CEBA or CEAB	AOLP	2	12	2	9	2	8	ns
<sup>t</sup> PHZ	0504	A at D	2	9	2	7.5	2	6.5	
<sup>t</sup> PLZ	OEBA or OEAB	A or B	2	9	2	7.5	2	6.5	ns
<sup>t</sup> PHZ	CEBA or CEAB	A or B	2	9	2	7.5	2	6.5	
<sup>t</sup> PLZ		AUB	2	9	2	7.5	2	6.5	ns



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PARAMETER MEASUREMENT INFORMATION

- NOTES: A. C<sub>L</sub> includes probe and jig capacitance.
  - B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
     C. The outputs are measured one at a time with one input transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms





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# **PACKAGING INFORMATION**

Orderable Device	Status <sup>(1)</sup>	Package Type	Package Drawing	Pins	Package Qty	Eco Plan <sup>(2)</sup>	Lead/ Ball Finish	MSL Peak Temp <sup>(3)</sup>	Samples (Requires Login)
74FCT2543ATSOCTE4	ACTIVE	SOIC	DW	24		TBD	Call TI	Call TI	
74FCT2543ATSOCTG4	ACTIVE	SOIC	DW	24		TBD	Call TI	Call TI	
CY74FCT2543ATQCT	ACTIVE	SSOP	DBQ	24	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	
CY74FCT2543ATQCTE4	ACTIVE	SSOP	DBQ	24	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	
CY74FCT2543ATQCTG4	ACTIVE	SSOP	DBQ	24	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	
CY74FCT2543ATSOC	ACTIVE	SOIC	DW	24	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	
CY74FCT2543ATSOCE4	ACTIVE	SOIC	DW	24	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	
CY74FCT2543ATSOCG4	ACTIVE	SOIC	DW	24	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	
CY74FCT2543ATSOCT	OBSOLETE	SOIC	DW	24		TBD	Call TI	Call TI	
CY74FCT2543CTQCT	ACTIVE	SSOP	DBQ	24	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	
CY74FCT2543CTQCTE4	ACTIVE	SSOP	DBQ	24	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	
CY74FCT2543CTQCTG4	ACTIVE	SSOP	DBQ	24	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	
CY74FCT2543CTSOC	ACTIVE	SOIC	DW	24	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	
CY74FCT2543CTSOCE4	ACTIVE	SOIC	DW	24	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	
CY74FCT2543CTSOCG4	ACTIVE	SOIC	DW	24	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.



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<sup>(2)</sup> Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

**TBD:** The Pb-Free/Green conversion plan has not been defined.

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Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

<sup>(3)</sup> MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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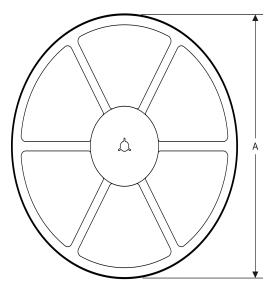
# PACKAGE MATERIALS INFORMATION

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# TAPE AND REEL INFORMATION

#### REEL DIMENSIONS

Texas Instruments





TAPE AND REEL INFORMATION

#### TAPE DIMENSIONS



A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

*All dimensions are nominal												
Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CY74FCT2543ATQCT	SSOP	DBQ	24	2500	330.0	16.4	6.5	9.0	2.1	8.0	16.0	Q1
CY74FCT2543CTQCT	SSOP	DBQ	24	2500	330.0	16.4	6.5	9.0	2.1	8.0	16.0	Q1

TEXAS INSTRUMENTS

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# PACKAGE MATERIALS INFORMATION

17-Aug-2012



\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)	
CY74FCT2543ATQCT	SSOP	DBQ	24	2500	367.0	367.0	38.0	
CY74FCT2543CTQCT	SSOP	DBQ	24	2500	367.0	367.0	38.0	

DW (R-PDSO-G24)

PLASTIC SMALL OUTLINE



NOTES: A. All linear dimensions are in inches (millimeters). Dimensioning and tolerancing per ASME Y14.5M-1994.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).

D. Falls within JEDEC MS-013 variation AD.



DBQ (R-PDSO-G24)

PLASTIC SMALL-OUTLINE PACKAGE



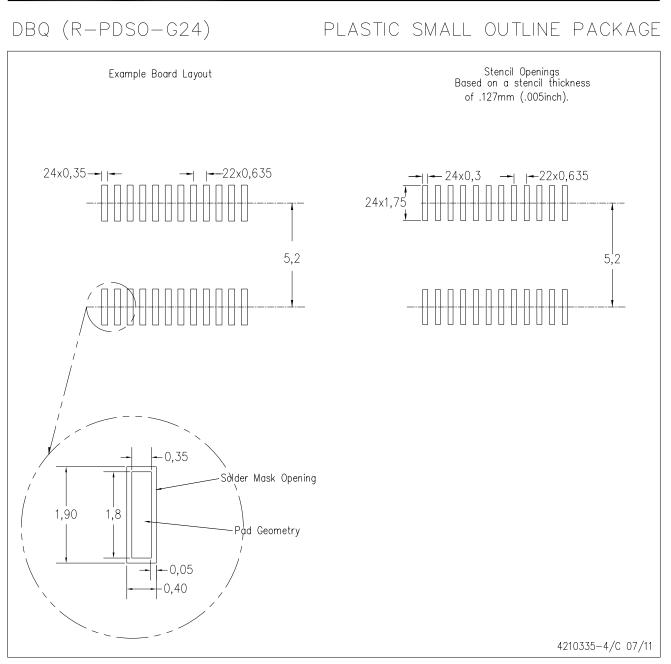
NOTES: A. All linear dimensions are in inches (millimeters).

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15) per side.

D. Falls within JEDEC MO-137 variation AE.





NOTES:

- A. All linear dimensions are in millimeters.B. This drawing is subject to change without notice.
- C. Customers should place a note on the circuit board fabrication drawing not to alter the center solder mask defined pad.
- D. Publication IPC-7351 is recommended for alternate designs.
- E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Example stencil design based on a 50% volumetric metal load solder paste. Refer to IPC-7525 for other stencil recommendations.



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